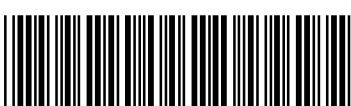


Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10520310	VAN DER MARK ET AL.
	Examiner	Art Unit
	HENOK G HEYI	2627

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
searched class 369/13.13, 13.17, 13.18, 13.19 and 13.33 - text search only (see search history printout) and also consulted primary Tan Dinh.	11/29/2007	HH
Updated search.	07/24/2008	HH
Conducted more search on EAST.	12/05/2008	HH
Updated search.	06/05/2009	HH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
369	13.01	01/13/2010	HH

/HENOK G HEYI/
Examiner.Art Unit 2627